Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/037,755	CHO ET AL.
Examiner	Art Unit
Frin M. File	2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	261	5/4/2007	EMF	
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH S		)
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EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	5/4/2007	EMF
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